

Vishay Siliconix

N-Channel 20 V (D-S) MOSFET

PRODUCT SUMMARY							
V _{DS} (V)	R _{DS(on)} (Ω) MAX.	I _D (A) ^a	Q _g (TYP.)				
20	0.072 at V _{GS} = 4.5 V	2.9					
	0.079 at V _{GS} = 2.5 V	2.8	3 nC				
	0.092 at V _{GS} = 1.8 V	2.6	3110				
	0.125 at V _{GS} = 1.5 V	2.2					

Marking Code: xx = AJ

xxx = Date/Lot traceability code

Ordering Information:

Si8810EDB-T2-E1 (lead (Pb)-free and halogen-free)

FEATURES

- TrenchFET® power MOSFET
- Ultra small 0.8 mm x 0.8 mm outline
- Ultra thin 0.357 mm height
- Typical ESD protection 2000 V (HBM)
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912

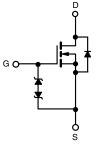
Pb-free

RoHS COMPLIANT

HALOGEN FREE

APPLICATIONS

- Portable devices such as cell phones, smart phones, and tablet PCs
 - Load switch
 - Small signal switch
 - High speed switching



N-Channel MOSFET

PARAMETER		SYMBOL	LIMIT	UNIT
Drain-Source Voltage		V _{DS}	20	V
Gate-Source Voltage		V _{GS}	± 8	V
	T _A = 25 °C		2.9 ^a	
Continuous Dunin Commant /T. 150 °C)	T _A = 70 °C	1 . 🗀	2.3 ^a	
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	2.1 ^b	
	T _A = 70 °C	Ī	1.7 ^b	Α
Pulsed Drain Current (t = 300 μs)		I _{DM}	15	
0 " 0 5 5 5 1 0 1	T _A = 25 °C	,	0.7 ^a	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	0.4 ^b	
	T _A = 25 °C		0.9 ^a	
Maniana Danian Disabatian	T _A = 70 °C		0.6 ^a	10/
Maximum Power Dissipation	T _A = 25 °C	P _D	0.5 ^b	W
	T _A = 70 °C		0.3 b	
Operating Junction and Storage Temperature	re Range	T _J , T _{stg}	-55 to +150	°C
Soldering Recommendations (Peak Temperature	ature) ^c		260	

THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT			
Maximum Junction-to-Ambient a, d	t ≤ 5 s	D	105	135	°C/W		
Maximum Junction-to-Ambient b, e	1 2 3 5	R _{thJA}	200	260]		

Notes

- a. Surface mounted on 1" x 1" FR4 board with full copper, t = 5 s.
- b. Surface mounted on 1" x 1" FR4 board with minimum copper, $t=5\ s.$
- c. Refer to IPC/JEDEC® (J-STD-020), no manual or hand soldering.
- d. Maximum under steady state conditions is 185 °C/W.
- e. Maximum under steady state conditions is 330 °C/W.



www.vishay.com Vishay Siliconix

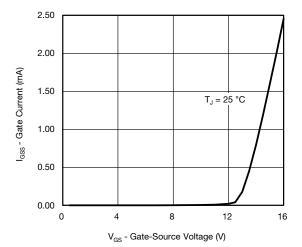
SPECIFICATIONS (T _J = 25 °C, unless otherwise noted)							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static		1	L	1	l	l.	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			21	-	mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-2.7	-		
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_{D} = 250 \mu A$	0.4	-	0.9	V	
	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	-	-	± 0.5	μΑ	
Gate-Source Leakage		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 5		
Zana Oala Wallana Baria Oana d		V _{DS} = 20 V, V _{GS} = 0 V	-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 55 °C	-	-	10		
On-State Drain Current ^a			10	-	-	Α	
		V _{GS} = 4.5 V, I _D = 1 A	-	0.058	0.072	1	
Durin On the On Olela Basisla and 2	5	V _{GS} = 2.5 V, I _D = 1 A	-	0.063	0.079	Ω	
Drain-Source On-State Resistance a	R _{DS(on)}	V _{GS} = 1.8 V, I _D = 1 A	-	0.072	0.092		
		V _{GS} = 1.5 V, I _D = 0.5 A	-	0.080	0.125		
Forward Transconductance a	9 _{fs}	V _{DS} = 10 V, I _D = 1 A	-	12	-	S	
Dynamic ^b				•			
Input Capacitance	C _{iss}		-	245	-	pF	
Output Capacitance	C _{oss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	55	-		
Reverse Transfer Capacitance	C _{rss}		-	25	-		
Tatal Oata Ohawaa	Q _g	V _{DS} = 10 V, V _{GS} = 8 V, I _D = 1 A	-	5.2	8	nC	
Total Gate Charge			-	3	4.5		
Gate-Source Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1 \text{ A}$	-	0.35	-		
Gate-Drain Charge	Q_{gd}		-	0.45	-		
Gate Resistance	R_g	f = 1 MHz	-	5	-	Ω	
Turn-On Delay Time	t _{d(on)}		-	7	15	ns	
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 10 \Omega$	-	12	25		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	=	25	50		
Fall Time	t _f		-	7	15		
Turn-On Delay Time	t _{d(on)}		-	5	10		
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 10 \Omega$	-	10	20		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$	-	15	30		
Fall Time	t _f		-	7	15		
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C	-	-	0.7	А	
Pulse Diode Forward Current	I _{SM}		-	-	15	^	
Body Diode Voltage	V _{SD}	I _S = 1 A, V _{GS} = 0 V	-	0.7	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}		-	11	20	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 1 A, dl/dt = 100 A/μs, T _J = 25 °C	-	5	10	nC	
Reverse Recovery Fall Time	t _a	$I_{F} = IA$, $aI/aI = I00AV\mu S$, $IJ = 25$	-	7	-	ne	
Reverse Recovery Rise Time			-	4	-	ns	

Notes

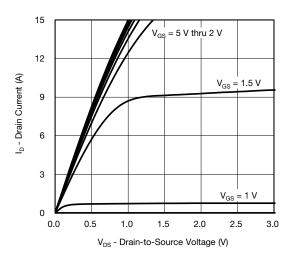
- a. Pulse test; pulse width $\leq 300 \,\mu\text{s}$, duty cycle $\leq 2 \,\%$.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

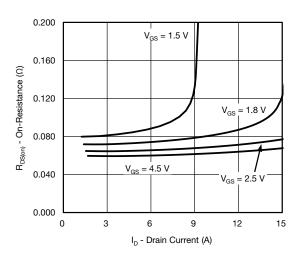




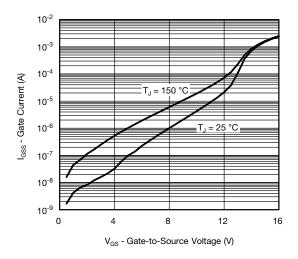
Gate Current vs. Gate-Source Voltage



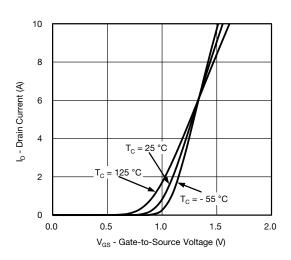
Output Characteristics



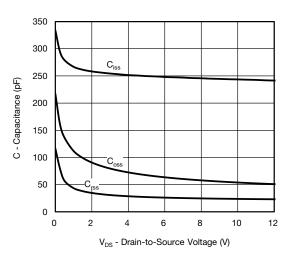
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage

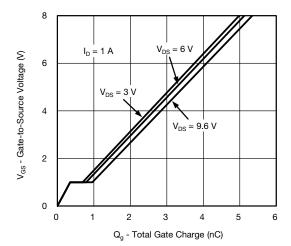


Transfer Characteristics

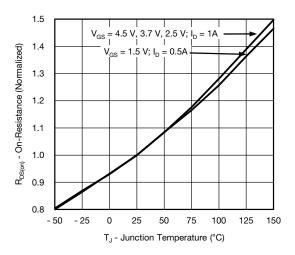


Capacitance vs. Drain-to-Source Voltage

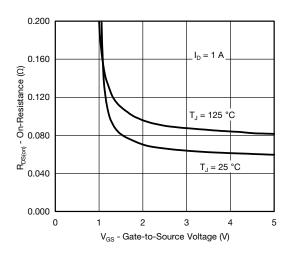




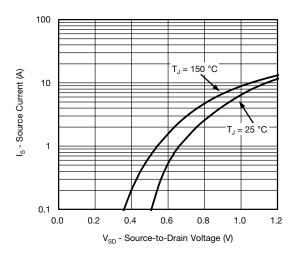
Gate Charge



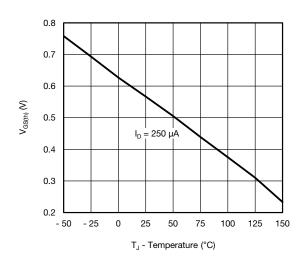
On-Resistance vs. Junction Temperature



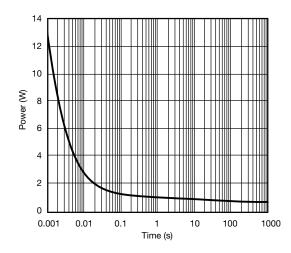
On-Resistance vs. Gate-to-Source Voltage



Source-Drain Diode Forward Voltage

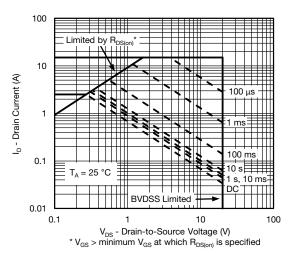


Threshold Voltage

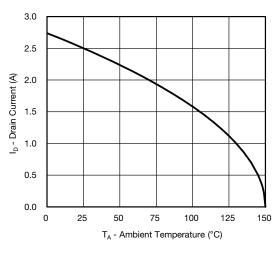


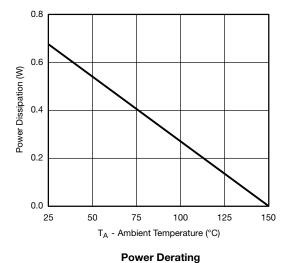
Single Pulse Power (Junction-to-Ambient)





Safe Operating Area, Junction-to-Ambient



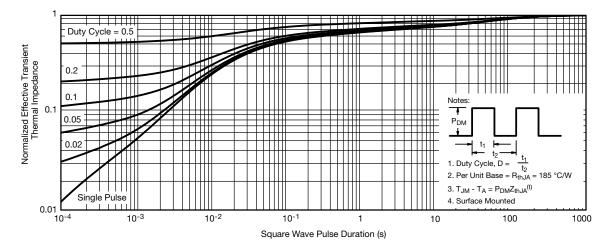


Current Derating*

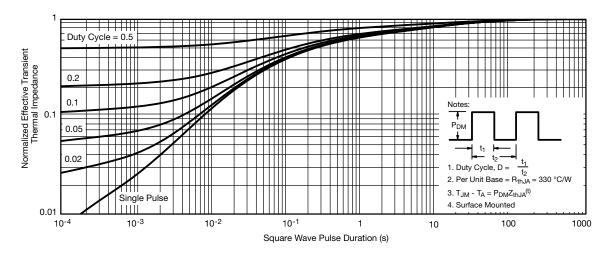
Note
When mounted on 1" x 1" FR4 with full copper.

^{*} The power dissipation P_D is based on $T_{J \text{ (max.)}} = 150 \,^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with maximum copper)

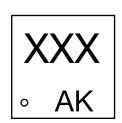


Normalized Thermal Transient Impedance, Junction-to-Ambient (on 1" x 1" FR4 board with minimum copper)

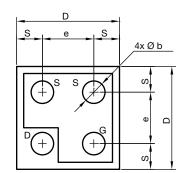
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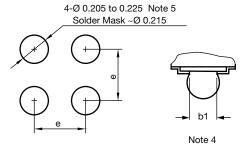
Vishay Siliconix

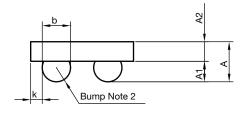
MICRO FOOT®: 4-Bump (0.8 mm x 0.8 mm, 0.4 mm Pitch)



Mark on Backside of die







Notes

- (1) Laser mark on the backside surface of die
- (2) Bumps are 95.5 % Sn,3.8 % Ag,0.7 % Cu
- (3) "i" is the location of pin 1
- (4) "b1" is the diameter of the solderable substrate surface, defined by an opening in the solder resist layer solder mask defined.
- (5) Non-solder mask defined copper landing pad.

DIM.	MILLIMETERS a			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.328	0.365	0.402	0.0129	0.0144	0.0158	
A1	0.136	0.160	0.184	0.0053	0.0062	0.0072	
A2	0.192	0.205	0.218	0.0076	0.0081	0.0086	
b	0.200	0.220	0.240	0.0078	0.0086	0.0094	
b1	0.175			0.0068			
е	0.400			0.0157			
S	0.160	0.180	0.200	0.0062	0.0070	0.0078	
D	0.720	0.760	0.800	0.0283	0.0299	0.0314	
K	0.040	0.070	0.100	0.0015	0.0027	0.0039	

Note

a. Use millimeters as the primary measurement.

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Revision: 16-Feb-15 1 Document Number: 69442



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Vishay

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